

Notice of References Cited

Application/Control No.

10/564,658

Applicant(s)/Patent Under

Reexamination

BECHTEL ET AL.

Examiner

Matthew W. Such

Art Unit

2891

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|--|-----------------|-------------------------------|----------------|
| * | A US-2003/0213955 | 11-2003 | Noguchi et al. | 257/59 |
| * | B US-6,894,431 | 05-2005 | Yamazaki et al. | 313/498 |
| * | C US-6,639,358 | 10-2003 | Ishikawa et al. | 313/504 |
| * | D US-6,569,697 | 05-2003 | Lu et al. | 438/22 |
| * | E US-6,133,581 | 10-2000 | Terao et al. | 257/40 |
| * | F US-5,399,936 | 03-1995 | Namiki et al. | 313/504 |
| * | G US-5,986,391 | 11-1999 | Feldman, Bernard | 313/326 |
| * | H US-4,859,036 | 08-1989 | Yamanaka et al. | 349/147 |
| * | I US-7,368,659 | 05-2008 | Heller, Christian Maria Anton | 136/263 |
| * | J US-5,323,252 | 06-1994 | Yoshida et al. | 349/148 |
| * | K US-6,525,467 | 02-2003 | Eida et al. | 313/506 |
| * | L US-6,930,448 | 08-2005 | Kim, Chang Nam | 313/506 |
| * | M US-6,140,765 | 10-2000 | Kim et al. | 313/506 |

FOREIGN PATENT DOCUMENTS

| * | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|--|-----------------|-----------------|-----------------|----------------|
| N | EP 888035 A1 | 12-1998 | European Patent | HOSOKAWA et al. | |
| O | | | | | |
| P | | | | | |
| Q | | | | | |
| R | | | | | |
| S | | | | | |
| T | | | | | |

NON-PATENT DOCUMENTS

| * | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|
| U | |
| V | |
| W | |
| X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.